


<p style="text-align: center;">Searched</p> 	<p>Application/Control No.</p> <p>10824929</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>PARK ET AL.</p>
	<p>Examiner</p> <p>Appiah, Charles N</p>	<p>Art Unit</p> <p>2617</p>

Class	SubClass	Date	Examiner
455	453.1,435.2,503,552.1,553.1,466,4 45,453,511,561,424,426.1	05/26/2006	CA
370	321,230,231,338,329,442,466,466, 324, 328,352		
U.S. Patent and Trademark Office		Part of Paper No.:	20060526

Search Notes

Application/Control No.

10/824,929

Examiner

Charles N. Appiah

Applicant(s)/Patent under
Reexamination

PARK ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
455	552.1,553. 1,445,435. 1,453.2	5/26/2006	CA
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	466,453		
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370	230,231		
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	329,338		
	442,466,		
	467,352		
	324		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
See attached search report		5/26/2006	

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See attached Search Reports	5/26/2006	CA